

Search Notes



Application/Control No.

10/613,332

Examiner

Mark K. Han

Applicant(s)/Patent under Reexamination

LEE ET AL.

Art Unit

3763

SEARCHED

Class	Subclass	Date	Examiner
604	96.01	7/11/2005	mbh.
	103.06		
	103.07		
	103.08		
	103.09		
	103.11		
428	36.9		
525	166		
	179		
606	192		
	193		
	194		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST text search	7/11/2005	mbh.
Inventor name search	7/11/2005	mbh.